TOSHIBA TA7522S/F

TOSHIBA BIPOLAR LINEAR INTEGRATED CIRCUIT SILICON MONOLITHIC

TA7522S, TA7522F

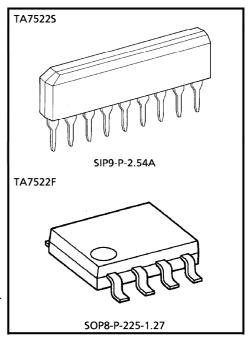
DUAL VOLTAGE COMPARATOR

The TA7522S, TA7522F is an easy-to-use small 9-pin single in-line package IC incorporating two voltage comparator circuits.

Since one channel has an inverted-output buffer, a CR oscillator can be easily built up. In addition, the IC has so wide an operating temperature range that it can be used in wide application fields.

FEATURES

- Two-circuit package
- High gain
- Single 3V power supply for operation
- Inverted-output also available
- A 0V input causes action in the IC with a single power supply.
- Wide common-mode input range
- No latch-up
- Operating temperature range : from -40 to 85°C
- Open-collector output
- SIP-9 pin (TA7522S)
- Small SOP-8 pin (TA7522F)



Weight

SIP9-P-2.54A : 0.92g (Typ.) SOP8-P-225-1.27 : 0.08g (Typ.)

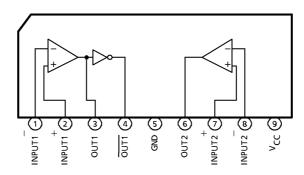
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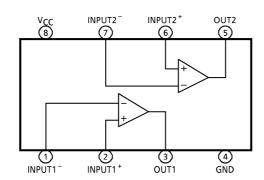
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BLOCK DIAGRAM AND PIN LAYOUT

TA7522S



TA7522F



Note: The TA7522S and TA7522F are the same chip, except that they are housed in different packages.

PIN DESCRIPTION

PIN No.		SYMBOL	DESCRIPTION	
TA7522S	TA7522F	STIVIBOL	DESCRIPTION	
1	1	INPUT1-	Inverted-input pin	
2	2	INPUT1+	Non-inverted-input pin	
3	3	OUT1	Output pin corresponding to INPUT1	
4	_	OUT1	Output pin for inversion of OUT1	
5	4	GND	Grounded	
6	5	OUT2	Output pin corresponding to INPUT2	
7	6	INPUT2+	Non-inverted-input pin	
8	7	INPUT2-	Inverted-input pin	
9	8	Vcc	Power supply pin	

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage	Vcc	-0.3 to +18	V
Supply Voltage Surge	VCC SURGE	+ 30 (within 1 second)	>
Power Dissipation	P _D	500 / 440	mW
Differential Input Voltage	DVIN	± 18	٧
Input Voltage	V _{IN}	-0.3 to +18	V
Output Current	^I SINK	30	mΑ
Operating Temperature	T _{opr}	-40 to +85	°C
Storage Temperature	T _{stg}	- 55 to + 150	°C

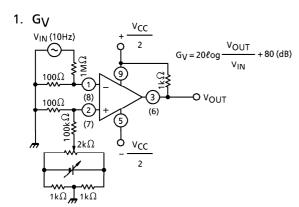
(Note) $P_D: TA7522S/TA7522F$

ELECTRICAL CHARACTERISTICS (Ta = $-40 \text{ to } +85^{\circ}\text{C}$)

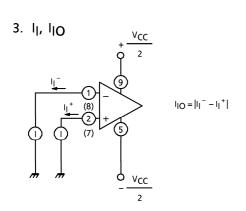
CHARACTERISTIC	SYMBOL		TEST CIR- CUIT	TEST CONDITION	MIN.	(Note) TYP.	MAX.	UNIT
Voltage Gain	GV		1	$V_{CC} = 6V$, $R_L = 1k\Omega$ f = 10Hz, test circuit 1	60	95	1	dB
Input Offset Voltage	V _{IO}		2	$V_{CC} = 6V$, $R_L = 1k\Omega$ $CMV_{IN} = 3V$, test circuit 2	-	2	10	mV
Input Bias Current	Ι _Ι		3	V _{CC} = 6V, CMV _{IN} = 3V test circuit 3		-0.2	- 2	μ A
Input Offset Current	liO		3	Same as above	_	0.02	0.3	μ A
Common-mode Input Voltage	CMVIL		4	$V_{CC} = 6.5V$, $R_L = 1k\Omega$ $V_{IO} = 20mV$, test circuit 4	_	- 0.5	0	٧
	CMVIH			Same as above	5.0	5.3	_	V
	V _{OL}	OUT1 OUT2	5	$V_{CC} = 5.5V$, $V_{IN} = 0.1V$ $I_{OL} = 10$ mA, test circuit 5		0.18	0.4	V
Zero Output Voltage		OUT1		$V_{CC} = 5.5V$, $V_{IN} = 0.1V$, $I_{OL} = 15mA$, V_{OL} (out1) $\ge 2V$, test circuit 5	ı	0.25	0.4	٧
Output Leakage Current	ILEAK	OUT1 OUT1 OUT2	6	V _{CC} = 6V, V _{OUT} = 30V test circuit 6	_		10	μΑ
		OUT1	6	$V_{CC} = 6V$, $V_{OUT} = 0.4V$ test circuit 6	_	- 1.5	- 10	μΑ
Current Consumption	lcc		7	$V_{CC} = 6.5V$, $R_L = \infty$ test circuit 7	_	3	7	mA

Note: An ambient temperature of 25°C is assumed for the typical values.

TEST CIRCUIT (Shown below is an example for the TA7522S. For the TA7522F, note that the pin numbers are different.)



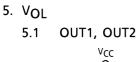
2. $V_{IO} = \frac{V_{CC}}{2}$ $V_{IO} = \frac{V_{OUT}}{100}$ $V_{IO} = \frac{V_{OUT}}{100}$ $V_{IO} = \frac{V_{OUT}}{100}$

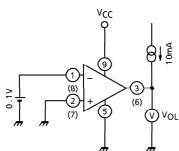


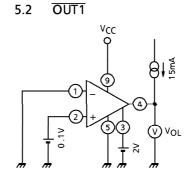
4. CMV_{IL}, CMV_{IH} V_{CC} V_{IN} V_{IN}

 $\mathsf{CMV}_{\mathsf{IL}}$: Input voltage relative to pin 5 as it is obtained when V_{IN} is decreased until output $\mathsf{V}_{\mathsf{OUT}}$ becomes $\pm 2\mathsf{V}$.

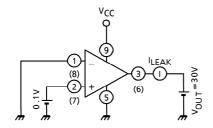
 CMV_{IH} : Input voltage relative to pin 5 as it is obtained when V_{IN} is increased until output V_{OUT} becomes $\pm 2\mathsf{V}$.



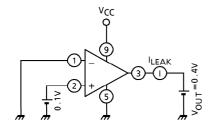




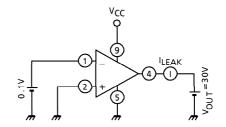
- 6. ILEAK
 - 6.1 OUT1, OUT2



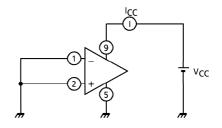
6.3 OUT1



6.2 <u>OUT1</u>

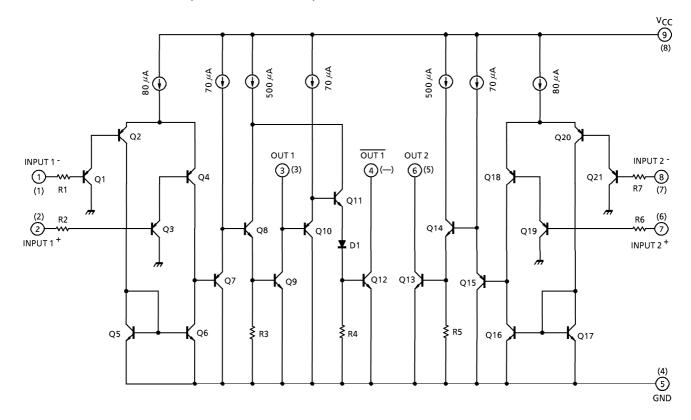


7. Icc



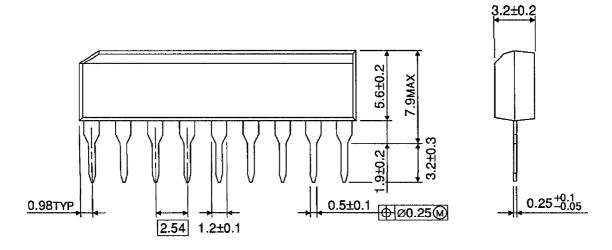
All inputs are grounded.

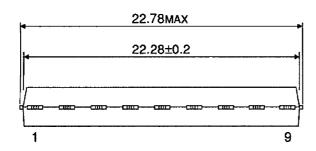
EQUIVALENT CIRCUIT (The pin numbers are explained in order of the TA7522S and the TA7522F.)



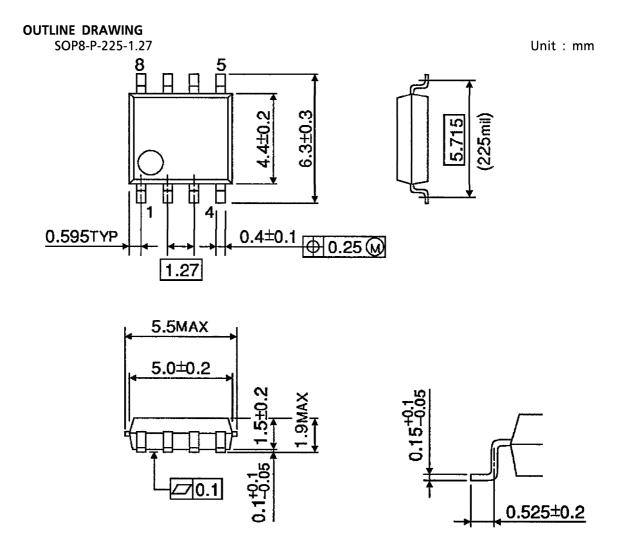
OUTLINE DRAWING

SIP9-P-2.54A Unit: mm





Weight: 0.92g (Typ.)



Weight: 0.08g (Typ.)